



SIDC14D120H6

Fast switching diode chip in EMCON-Technology

FEATURES:

- 1200V EMCON technology 120 μm chip
- soft, fast switching
- low reverse recovery charge
- small temperature coefficient

This chip is used for:

EUPEC power modules and discrete devices



Applications:

SMPS, resonant applications, drives

Chip Type	V_R	I _F	Die Size	Package	Ordering Code
SIDC14D120H6	1200V	25A	3.8 x 3.8 mm ²	sawn on foil	Q67050-A4096- A102

MECHANICAL PARAMETER:

•			
3.8 x 3.8			
14.44 / 9.8	mm ²		
3.08 x 3.08			
120	μm		
150	mm		
180	deg		
1018 pcs			
Photoimide			
3200 nm AlSiCu			
1400 nm Ni Ag -system suitable for epoxy and soft solder die bonding			
electrically conductive glue or solder			
AI, ≤500μm			
Ø 0.65mm ; max 1.2mm			
store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			
	14.44 / 9.8 3.08 x 3.08 120 150 180 1018 pcs Photoimide 3200 nm AlSiCu 1400 nm Ni Ag —system suitable for epoxy and soft solder die bon electrically conductive glue or solder Al, ≤500μm Ø 0.65mm ; max 1.2mm store in original container, in dry nitroge		



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Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V_{RRM}		1200	V
Continuous forward current limited by	I _F		25	
T _{jmax}	7 F		20	
Single pulse forward current	I _{FSM}	$t_P = 10 \text{ ms sinusoidal}$	tbd	Α
(depending on wire bond configuration)	, L 2 IVI	tr = 10 me emeerda.		
Maximum repetitive forward current	1		50	
limited by T _{jmax}	I _{FRM}		50	
Operating junction and storage temperature	$T_{\rm j}$, $T_{\rm stg}$		-55+150	°C

Static Electrical Characteristics (tested on chip), T_j =25 °C, unless otherwise specified

Parameter	Symbol	Cond	Value			Unit	
raiailietei	Symbol	Conditions		min.	Тур.	max.	Oiiit
Reverse leakage current	I_{R}	V _R =1200V	$T_j=25^{\circ}C$			27	μΑ
Cathode-Anode breakdown Voltage	V_{Br}	I _R =4mA	$T_j=25^{\circ}C$	1200			V
Forward voltage drop	V_F	I _F =25A	<i>T_j</i> =25° <i>C</i>		1.6		V

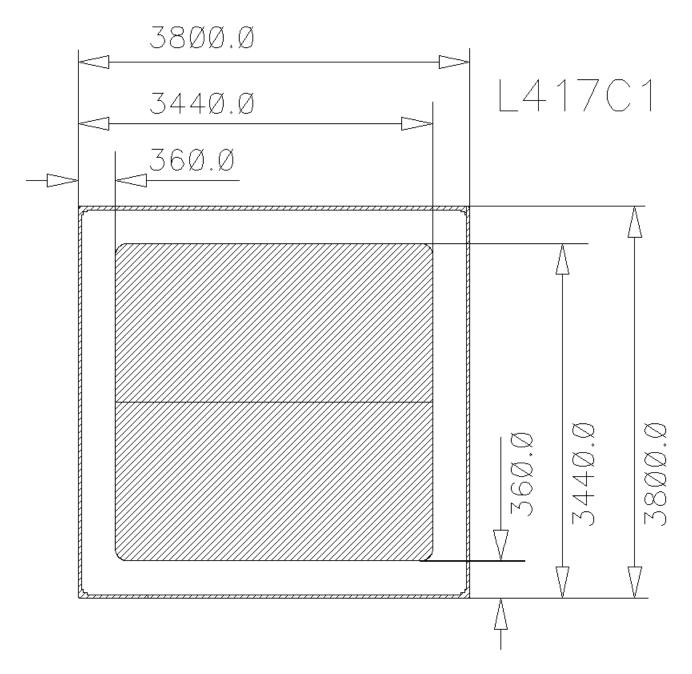
Dynamic Electrical Characteristics, at $T_j = 25$ °C, unless otherwise specified, tested at component

Parameter	Symbol	Conditions		Value			Unit
raiailietei	Syllibol			min.	Тур.	max.	
Reverse recovery time	t _{rr1}	I _F =25A	$T_j = 25 ^{\circ}C$		tbd		
	t _{rr2}	$di/dt=675A/\mu s$ $V_R=600V$	$T_j = 125 ^{\circ}C$				ns
Peak recovery current	I _{RRM1}	I _F =25A	$T_j = 25 ^{\circ}C$		36		Α
	I _{RRM2}	di/dt=675A/μs V _R = 600V	$T_j = 125 ^{\circ}C$		37.5		1
Reverse recovery charge	Q _{rr1}	I _F =25A	T _j =25° C		2.8		μC
	Q _{rr2}		T _j =125° C		5.1		
Peak rate of fall of reverse	di _{rr1} /dt	I _F =25A	T _j = 25° C		tbd		A / -
recovery current	di _{rr2} /dt	$di/dt=675A/\mu s$ $V_R=~600V$	T _j =125° C				A/μs
Softness	S1	I _F =25A	T _j =25° C		tbd		1
	S2	$di/dt=675A/\mu s$ $V_R=600V$	T _j =125° C				



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CHIP DRAWING:



Flatside

1 mm

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Preliminary

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FURTHER ELECTRICAL CHARACTERISTICS:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

This chip data sheet refers to the device data sheet	INFINEON TECHNOLOGIES / EUPEC	tbd	
Description:			

Test-Normen Villach/Prüffeld

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